

Notice of References Cited	Application/Control No. 10/797,492	Applicant(s)/Patent Under Reexamination QI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,842,141	01-2005	Suh et al.	343/700MS
	B	US-6,281,843	08-2001	Evtioughkine et al.	343/700MS
	C	US-6,265,977	07-2001	Vega et al.	340/572.7
	D	US-5,914,695	06-1999	Liu et al.	343/795
	E	US-5,914,497	06-1999	Sherwin, Mark	257/21
	F	US-5,293,175	03-1994	Hemmie et al.	343/795
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 6-27170 A	04-1994	Japan	Futaki et al.	G01R 29/08
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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